12X 12750 T Page 1 of 4 January 2011

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# CERTIFICATE OF ANALYSIS

12X 12750 (batch T)

# **Certified Reference Material Information**

Type: LOW-ALLOY STEEL (WROUGHT)

Form and Size: Disc ~40mm Diameter

Manufactured by: Polycast Ltd

Certified and Supplied by: MBH Analytical Ltd

# **Assigned Values**

#### Percentage element by weight

Element	С	Si	S	Р	Mn	Ni	Cr	Мо
Value 1	0.202	0.383	0.0082	0.0106	0.248	1.012	0.853	0.119
Uncertainty <sup>2</sup>	0.002	0.010	0.0004	0.0010	0.006	0.012	0.008	0.003

Element	Cu	Со	Sn	Al	V	W	Ti	Nb
Value <sup>1</sup>	0.0215	0.670	0.227	0.285	0.0961	0.105	0.116	0.120
Uncertainty 2	0.0008	0.010	0.004	0.005	0.0016	0.004	0.004	0.004

# **Definitions**

- The assigned values are the present best estimates of the true content for each element. Each value is a panel consensus, based on the averaged results of an interlaboratory testing programme, detailed on page 3.
- The uncertainty values are generated from the 95% confidence interval derived from the wet analysis results, in combination with a statistical assessment of the homogeneity data, as described on page 2.

# Certified by:

on 3<sup>rd</sup> January 2011

0.5

MBH ANALYTICAL LIMITED





# **Method of Preparation**

This reference material was produced from commercial-purity metals and master alloys. The discs are the product of one melt, cast into 70mm diameter billets and hot worked into bars of ~42mm diameter.

## Sampling

Milled samples for chemical analysis were taken from several positions within the batch. In addition, at least 15% of all discs were selected for homogeneity checking.

## Homogeneity

The discs were checked for lateral and batch uniformity using an optical emission spectrometer.

Using the meaned data from each surface, standard deviation values were derived for each element as an indicator of any non-homogeneity (as determined for the specific sample size taken by the spectrometer).

#### **Chemical Analysis**

Analysis was carried out on millings taken from samples representative of the product. It was performed by a panel of laboratories mostly operating within the terms of EN ISO/IEC 17025 - 2005, using documented standard reference methods and validated by appropriate reference materials.

The individual values listed overpage are the average of each analyst's results.

## **Estimation of Uncertainties**

Each element certified has been analysed by several laboratories, and 95% half-width confidence intervals ( $C_{(95\%)}$ ) for the resultant mean values have been derived by the method shown on page 3.

As a separate exercise, the degree of non-homogeneity of the batch for each element has been quantified by a programme of non-destructive application testing, discussed above.

The final certified uncertainty for each element has been derived by combining these two factors, using the square-root of the summed squares.

# **Traceability**

Much of the analytical work performed to assess this material has been carried out by laboratories with proven competence, as indicated by their accreditation to ISO 17025. It is an implicit requirement for this accreditation that analytical work should be performed with due traceability, via an unbroken chain of comparisons, each with stated uncertainty, to primary standards such as the mole, or to nationally- or internationally-recognised reference materials. In addition, some of the results derived as part of this testing programme have traceability to NIST standards, as part of the analytical calibration or process control.

## <u>Usage</u>

Intended use: With optical emission and X-ray fluorescence spectrometers.

Recommended method of use:

Steels are generally prepared by grinding. However, users are recommended to follow the calibration and sample preparation procedures specified by the relevant instrument manufacturer. Preparation should be the same for reference materials and the samples for test.

A minimum of five consistent replicate analyses is recommended to provide the necessary sample size. Users are advised to check against possible bias between reference materials and production samples due to differences in metallurgical history, and be aware of possible interelement effects.

# **Analytical Data**

Percentage element by weight								
Sample	С	Si	S	Р	Mn	Ni	Cr	Мо
1	0.199	0.364	0.0074	0.0089	0.234	0.980	0.834	0.112
2	0.200	0.367	0.0076	0.0090	0.236	0.993	0.835	0.112
3	0.200	0.368	0.0076	0.0092	0.238	0.997	0.846	0.114
4	0.200	0.370	0.0077	0.0093	0.245	1.004	0.856	0.117
5	0.201	0.388	0.0079	0.0105	0.248	1.011	0.857	0.118
6	0.201	0.391	0.0080	0.0113	0.248	1.016	0.857	0.119
7	0.202	0.392	0.0081	0.0116	0.250	1.018	0.858	0.120
8	0.203	0.395	0.0082	0.0116	0.253	1.023	0.859	0.120
9	0.204	0.398	0.0085	0.0120	0.258	1.026	0.863	0.121
10	0.204	0.401	0.0085	0.0124	0.259	1.031	0.868	0.121
11	0.207		0.0090		0.260	1.037		0.124
12			0.0095					0.127
Mean	0.202	0.383	0.0082	0.0106	0.248	1.012	0.853	0.119
Std Dev	0.002	0.014	0.0006	0.0014	0.009	0.017	0.011	0.005
C <sub>(95%)</sub>	0.002	0.010	0.0004	0.0010	0.006	0.012	0.008	0.003
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Sample	Cu	Со	Sn	Al	V	W	Ti	Nb
1	0.0200	0.650	0.219	0.270	0.0924	0.100	0.111	0.113
2	0.0205	0.652	0.221	0.279	0.0934	0.100	0.112	0.113
3	0.0210	0.656	0.222	0.280	0.0940	0.102	0.112	0.117
4	0.0212	0.663	0.222	0.280	0.0954	0.103	0.112	0.119
5	0.0212	0.670	0.225	0.281	0.0955	0.105	0.113	0.120
6	0.0217	0.672	0.225	0.285	0.0960	0.105	0.117	0.121
7	0.0218	0.679	0.225	0.285	0.0960	0.107	0.118	0.123
8	0.0222	0.683	0.225	0.289	0.0978	0.108	0.120	0.123
9	0.0223	0.685	0.230	0.289	0.0978	0.108	0.121	0.124
10	0.0231	0.685	0.232 0.234	0.290 0.290	0.0986 0.1005	0.110	0.123	0.126
11 12			0.234	0.290	0.1005			
13			0.238	0.294				
Mean	0.0215	0.670	0.227	0.285	0.0961	0.105	0.116	0.120
Std Dev	0.0009	0.014	0.006	0.007	0.0024	0.003	0.004	0.004
C <sub>(95%)</sub>	0.0007	0.010	0.004	0.004	0.0016	0.003	0.003	0.003

Note:  $C_{(95\%)}$  is the 95% half-width confidence interval derived from the equation:

 $C_{(95\%)} = (t \times SD)/\sqrt{n}$ 

where n is the number of available values, t is the Student's t value for n-1 degrees of freedom, and SD is the standard deviation of the test results.

## Participating Laboratories

Exova Materials Testing Ltd
IncoTest Ltd
Metals Technology Testing, Ltd
Universal Scientific Laboratory Pty
Genitest Inc
Institute of Iron & Steel Technology
Luo Yang Copper Co
Sargam Metals Pvt Ltd
TCR Engineering Servs Pvt Ltd
Raghavendra SpectroMet Laboratory
London & Scandinavian Met. Co Ltd
De Bruyn Spectroscopic Solutions
Coleshill Laboratories Ltd

Middlesbrough, England
Hereford, England
Sheffield,England
Milperra, NSW, Australia
Montreal, Canada
Shanghai, China
Luo Yang, He Nan, China
Chennai, India
Mumbai, India
Bangalore, India
Rotherham, England
Johannesburg, South Africa
Birmingham, England

UKAS accreditation 0239 UKAS accreditation 0281 UKAS accreditation 0963 NATA accreditation 0492 PRI accreditation 123077 CNAL accreditation 0783 CNAL accreditation 0173 NABL accreditation T025 NABL accreditation T367 NABL accreditation T371

Note: to achieve the above accreditation (eg UKAS, NATA, etc), test houses are required to demonstrate conformity to the general requirements of EN ISO/IEC 17025.

## **Analytical Methods Used**

ELEMENT			RESULT No. & METH	HOD
	ICP-AES	FAAS		OTHER
Carbon	-	-	all	combustion (IR or volumetric detection)
Silicon	2-4	-	1, 5, 7	photometric (molybdenum blue)
			6, 8-10	gravimetric (perchloric acid)
Sulfur	4, 9	-	1-3, 5-8, 10-12	combustion (IR or volumetric detection)
Phosphorus	1, 7-10	-	2, 5, 6	photometric (molybdenum blue)
			3, 4	volumetric (alkalimetric)
Manganese	1, 3, 6-8, 10, 11	4	2	volumetric (arsenite)
			5, 9	photometric (periodate)
Nickel	1-6, 8	7, 11	9	photometric (dimethyl glyoxime)
			10	volumetric (DMGO/EDTA)
Chromium	1-3, 5-7, 9	4, 8	10	volumetric (ferrous ammonium sulfate)
Molybdenum	1, 2, 4, 7-9, 11, 12	3, 6	5, 10	photometric (thiocyanate)
Copper	1, 3, 5-7, 10	2, 4, 8, 9		
Cobalt	1, 2, 6-9	3, 5, 10	4	photometric (5-chloro PADAB)
Tin	1-3, 8-13	4-6	7	photometric (phenylfluorone)
Aluminium	3, 4, 6-8, 10, 12, 13	1, 9, 11	2, 5	photometric (chrome azurol S)
Vanadium	3, 4, 6, 7, 10, 11	1, 2, 8	5, 9	volumetric (ferrous ammonium sulfate)
Tungsten	1, 2, 6-8, 10	9	4	gravimetric (cinchonine)
			3, 5	photometric (thiocyanate)
Titanium	1-3, 5-7	4, 8	9, 10	photometric (di-antipyryl methane)
Niobium	2, 3, 5-7, 9	1, 4	8, 10	photometric (chlorosulfophenol)

#### **Notes**

This Certified Reference Material has been produced and certified in accordance with the requirements of ISO Guide 34-2009, ISO Guide 31-2000 and ISO Guide 35-2006, taking into account the requirements of the ISO Guide to the Expression of Uncertainty in Measurement (GUM).

This certification is applicable to the whole of the disc. However, in accordance with normal practice for emission spectrometry, it is appropriate to avoid usage of the centre of the disc, ~8 mm diameter.

This material will remain stable indefinitely, provided adequate precautions are taken to protect it from cross-contamination, extremes of temperature and atmospheric moisture. All production records will be retained for a period of 20 years from the date of this certificate. This certification will therefore expire in January 2031, although we reserve the right to make changes as issue revisions, in the intervening period.

This sample is also available in the form of chippings.

The manufacture, analysis and certification of this product were supervised by C Eveleigh, PhD, Technical Director, MBH Analytical Ltd.

The material to which this certificate of analysis refers is supplied subject to our general conditions of sale.